



**FOR IMMEDIATE RELEASE**

**Contact:**

Marilynn Meek  
Financial Relations Board  
Analyst/Investor Contact  
(212) 827-3773

**AEHR TEST SYSTEMS REGAINS COMPLIANCE WITH NASDAQ MINIMUM BID PRICE RULE**

**Fremont, CA (April 17, 2012) - Aehr Test Systems (Nasdaq: AEHR)**, a worldwide supplier of semiconductor test and burn-in equipment, today announced that it has received a letter dated April 17, 2012 from the Nasdaq Stock Market (“Nasdaq”), confirming that the Company has regained compliance with the \$1.00 minimum closing bid price requirement for continued listing on The Nasdaq Capital Market under Listing Rule 5550(a)(2) (the “Minimum Bid Price Rule”). Pursuant to Nasdaq’s rules, the Company was required to achieve a closing bid price of at least \$1.00 per share for 10 consecutive trading days. The Company completed the requirement on April 16, 2012, and the Company believes it currently meets all requirements for continued listing on the Nasdaq Capital Market. The Company’s shares continue to be listed on the Nasdaq Capital Market and its ticker symbol of “AEHR” remains unchanged.

**About Aehr Test Systems**

Headquartered in Fremont, California, Aehr Test Systems is a worldwide provider of systems for burning-in and testing DRAMs, flash and other memory and logic integrated circuits and has an installed base of more than 2,500 systems worldwide. Aehr Test has developed and introduced several innovative products, including the ABTS™, FOX™ and MAX systems and the DiePak® carrier. The ABTS system is Aehr Test’s newest system for packaged part test during burn-in for both low-power and high-power logic as well as all common types of memory devices. The FOX system is a full wafer contact test and burn-in system. The MAX system can effectively burn-in and functionally test complex devices, such as digital signal processors, microprocessors, microcontrollers and systems-on-a-chip. The DiePak carrier is a reusable, temporary package that enables IC manufacturers to perform cost-effective final test and burn-in of bare die. For more information, please visit the Company’s website at [www.aehr.com](http://www.aehr.com).

**Safe Harbor Statement**

This release contains forward-looking statements that involve risks and uncertainties relating to projections regarding revenues, net sales and customer demand and acceptance of Aehr Test’s products. Actual results may vary from projected results. These risks and uncertainties include

without limitation, world economic conditions, the state of the semiconductor equipment market, the Company's ability to maintain sufficient cash to support operations, acceptance by customers of Aehr Test's technologies, acceptance by customers of the systems shipped upon receipt of a purchase order, the ability of new products to meet customer needs or perform as described and the Company's ability to successfully market a wafer-level test and burn-in system. See Aehr Test's recent 10-K, 10-Q and other reports from time to time filed with the U.S. Securities and Exchange Commission for a more detailed description of the risks facing our business. The Company disclaims any obligation to update information contained in any forward-looking statement to reflect events or circumstances occurring after the date of this press release.

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